

High-Performance Driver/Comparator Active Load on a Single Chip

AD53509

FEATURES

250 MHz Operation
Driver/Comparator and Active Load Included
On-Chip Schottky Diode Bridge
52-Lead LQFP Package with Built-In Heat Sink

APPLICATIONS
Automatic Test Equipment
Semiconductor Test Systems
Board Test Systems
Instrumentation and Characterization Equipment

PRODUCT DESCRIPTION

The AD53509 is a single chip that performs the pin electronics functions of driver, comparator and active load in ATE VLSI and memory testers. In addition, a Schottky diode bridge for the active load and a VCOM buffer are included internally.

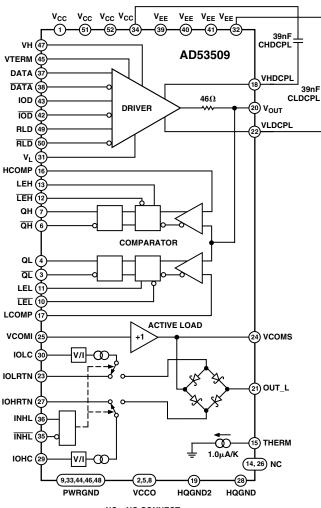
The driver is a proprietary design that features three active states: Data High Mode, Data Low Mode and Term Mode as well as an Inhibit State. This facilitates the implementation of high speed active termination. The output voltage range is -2 V to +7 V to accommodate a wide variety of test devices. The output leakage is typically less than 250 nA over the entire signal range.

The dual comparator, with an input range equal to the driver output range, features built-in latches and ECL-compatible outputs. The outputs are capable of driving 50 Ω signal lines terminated to -2 V. Signal tracking capability is upwards of 5 V/ns.

The active load can be set for up to 40 mA load current with less than a 10 μ A linearity error through the entire set range. I_{OH}, I_{OL} and the buffered VCOM are independently adjustable. On-board Schottky diodes provide high speed switching and low capacitance.

Also included on the chip is an on-board temperature sensor whose purpose is to give an indication of the surface temperature of the DCL. This information can be used to measure θ_{JC} and θ_{JA} or flag an alarm if proper cooling is lost. Output from the sensor is a current sink that is proportional to absolute temperature. The gain is trimmed to a nominal value of 1.0 $\mu A/K$. As an example, the output current can be sensed by using a 10 k Ω resistor connected from 10 V to the THERM (IOUT) pin. A voltage drop across the resistor will be developed that equals: $10K\times 1~\mu A/K=10~mV/K=2.98~V$ at room temperature.

FUNCTIONAL BLOCK DIAGRAM



NC = NO CONNECT

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AD53509—SPECIFICATIONS DRIVER SPECIFICATIONS

(All specifications are at $T_J = 85^{\circ}\text{C} \pm 5^{\circ}\text{C}$, $V_S = 11 \text{ V} \pm 3\%$, $-V_S = -6 \text{ V} = \pm 3\%$ unless otherwise noted. All temperature coefficients are measured at $T_J = 75^{\circ}\text{C}$ to 95°C .)

| Parameter | Min | Typ | Max | Unit | Test Conditions |
|--|---|--------------|-----------------|--------------------------------|--|
| DIFFERENTIAL INPUT CHARACTERISTICS | 3 | | | | |
| (DATA to \overline{DATA} , IOD to \overline{IOD} , RLD to \overline{RLD}) | | | | | |
| Input Voltage | -2 | | +3 | V | |
| Differential Input Range | 250 | | 2 | V | All Digital Inputs Within a 2 V Range |
| Bias Current | -250 | | +250 | μΑ | $V_{\rm IN} = -2 \text{ V}, +3 \text{ V}$ |
| REFERENCE INPUTS | | | . = 0 | | |
| Bias Currents | -50 | | +50 | μΑ | V_L , V_H , $V_T = 5 V$ |
| OUTPUT CHARACTERISTICS | | | | | |
| Logic High Range | -2 | | +7 | V | DATA = H, $V_H = -2 V$ to +7 V, $V_L = -2 V$, $V_T = 0 V$ |
| Logic Low Range | -2 | | +6 | V | DATA = L, $V_L = -2 \text{ V to } +6 \text{ V}, V_H = 7 \text{ V}, V_T = 0 \text{ V}$ |
| Amplitude (V_H and V_L) | 0.1 | | 9 | V | $V_{L} = 0.0 \text{ V}, V_{H} = 0.1 \text{ V}, V_{T} = 0 \text{ V}$ |
| Absolute Accuracy | 50 | | .50 | *** | $V_L = -2 \text{ V}, V_H = +7 \text{ V}, V_T = 0 \text{ V}$ |
| V _H Offset | -50 0.3 - 5 | | +50 | mV | DATA = H, $V_H = 0$ V, $V_L = -2$ V, $V_T = -1$ V |
| V _H Gain + Linearity Error | 0.5 – 5 –50 | | +0.3 + 5 | $\%$ of $V_H + mV$ | DATA = H, $V_H = -1$ V to +7 V, $V_L = -2$ V, $V_T = -2$ V |
| $ m V_L$ Offset $ m V_L$ Gain + Linearity Error | $\begin{vmatrix} -50 \\ -0.3 - 5 \end{vmatrix}$ | | +50 +0.3 + 5 | mV % of V _L + mV | DATA = L, $V_L = 0 V$, $V_H = 5 V$, $V_T = 3 V$ DATA = L, $V_L = -2 V$ to +6 V, $V_H = 7 V$, $V_T = 7 V$ |
| Offset TC | -0.5 - 5 | 0.5 | TU.5 T 5 | mV/°C | $V_{L} = -2 \text{ V}, V_{H} = 0 \text{ V}, V_{T} = -1 \text{ V} (V_{H} \text{ Offset})$ |
| onset 10 | | 0.5 | | mv/ C | $V_L = 2 \text{ V}, V_H = 0 \text{ V}, V_T = 1 \text{ V} (V_H \text{ Offset})$ $V_L = 0 \text{ V}, V_H = 5 \text{ V}, V_T = 3 \text{ V} (V_L \text{ Offset})$ |
| Output Resistance | | | | | L o i, in o i, iT - o i (iT onser) |
| $V_H = -2 \text{ V}$ | 44 | 46 | 48 | Ω | $V_L = -2 \text{ V}, V_T = 0 \text{ V}, I_{OUT} = 0, +1, +30 \text{ mA}$ |
| $V_H = +7 \text{ V}$ | 44 | 46 | 48 | Ω | $V_{\rm L} = -1 \text{ V}, V_{\rm T} = 0 \text{ V}, I_{\rm OUT} = 0, -1, -30 \text{ mA}$ |
| $V_{L} = -2 \text{ V}$ | 44 | 46 | 48 | Ω | $V_H = 6 \text{ V}, V_T = 0 \text{ V}, I_{OUT} = 0, 1, 30 \text{ mA}$ |
| $V_L = +6 \text{ V}$ | 44 | 46 | 48 | Ω | $V_{\rm H} = 7 \text{ V}, V_{\rm T} = 0 \text{ V}, I_{\rm OUT} = 0, -1, -30 \text{ mA}$ |
| $V_H = +3 \text{ V}$ | | 46 | | Ω | $V_L = 0 \text{ V}, V_T = 0 \text{ V}, I_{OUT} = -30 \text{ mA (Trim Point)}$ |
| Dynamic Current Limit | | >100 | | mA | $C_{BYP} = 39 \text{ nF}, V_H = 6 \text{ V}, V_L = -2 \text{ V}, V_T = 0 \text{ V}$ |
| Static Current Limit | -85 | | +85 | mA | Output to -2 V , $V_H = 7 \text{ V}$, $V_L = -1 \text{ V}$, $V_T = 0 \text{ V}$ |
| | | | | | DATA = H and Output to 7 V, $V_H = 6 V$, |
| | | | | | $V_L = -2 V$, $V_T = 0 V$, DATA = L |
| $\overline{ m V_{TERM}}$ | | | | | |
| Voltage Range | -2 | | +7 | V | TERM MODE, $V_T = -2 \text{ V to } +7 \text{ V}, V_L = 0 \text{ V}, V_H = 3 \text{ V}$ |
| V _{TERM} Offset | -50 | | +50 | mV | TERM MODE, $V_T = 0 \text{ V}$, $V_L = 0 \text{ V}$, $V_H = 3 \text{ V}$ |
| V _{TERM} Gain + Linearity Error | -0.3 +10 | | +0.3 +10 | % of V _{SET} + mV | TERM MODE, $V_T = -2 \text{ V to } +7 \text{ V}, V_L = 0 \text{ V}, V_H = 3 \text{ V}$ |
| Offset TC | | 0.5 | | mV/°C | $V_T = 0 \text{ V}, V_L = 0 \text{ V}, V_H = 3 \text{ V}$ |
| Output Resistance | 44 | 46 | 49 | Ω | $I_{OUT} = +30 \text{ mA}, +1.0 \text{ mA}, V_T = -2.0 \text{ V}, V_H = 3 \text{ V}, V_L = 0 \text{ V}$ |
| • | | | | | $I_{OUT} = -30 \text{ mA}, -1.0 \text{ mA}, V_T = +7.0 \text{ V}, V_H = 3 \text{ V}, V_L = 0 \text{ V}$ |
| | | | | | $I_{OUT} = \pm 30 \text{ mA}, \pm 1.0 \text{ mA}, V_T = 0 \text{ V}, V_H = 3 \text{ V}, V_L = 0 \text{ V}$ |
| DYNAMIC PERFORMANCE, (V _H AND V _L) | | | | | |
| Propagation Delay Time | | 1.5 | | ns | Measured at 50%, $V_H = +400 \text{ mV}$, $V_L = -400 \text{ mV}$, |
| | | | | | $V_T = 0 V$ |
| Propagation Delay TC | | 2 | | ps/°C | Measured at 50%, $V_H = +400 \text{ mV}$, $V_L = -400 \text{ mV}$, |
| | | | | | $V_T = 0 V$ |
| Delay Matching, Edge to Edge | | <100 | | ps | Measured at 50%, $V_H = +400 \text{ mV}$, $V_L = -400 \text{ mV}$, |
| Disc. and E-11 Times | | | | | $V_T = 0 V$ |
| Rise and Fall Times 1 V Swing | | 0.42 | | ne | Measured 20%–80%, $V_L = 0 \text{ V}$, $V_H = 1 \text{ V}$, $V_T = 0 \text{ V}$ |
| 3 V Swing | | 0.42 0.75 | | ns | Measured 20%–80%, $V_L = 0 \text{ V}$, $V_H = 1 \text{ V}$, $V_T = 0 \text{ V}$ Measured 20%–80%, $V_L = 0 \text{ V}$, $V_H = 3 \text{ V}$, $V_T = 0 \text{ V}$ |
| 5 V Swing 5 V Swing | | 1.65 | | ns ns | Measured 20%–80%, $V_L = 0 \text{ V}$, $V_H = 5 \text{ V}$, $V_T = 0 \text{ V}$ Measured 10%–90%, $V_L = 0 \text{ V}$, $V_H = 5 \text{ V}$, $V_T = 0 \text{ V}$ |
| 9 V Swing | | 3.0 | | ns | Measured 10%–90%, $V_L = 0 \text{ V}$, $V_H = 7 \text{ V}$, $V_T = 0 \text{ V}$ |
| Rise and Fall Time Temperature Coefficient | | 5.0 | | 110 | 111casured 10/0 20/0, v _L = -2 v, v _H = 1 v, v _T = 0 v |
| 1 V Swing | | ±1 | | ps/°C | Measured 20%–80%, $V_I = 0 \text{ V}$, $V_H = 1 \text{ V}$ |
| 3 V Swing | | ±2 | | ps/°C | Measured 20%–80%, $V_L = 0 \text{ V}$, $V_H = 1 \text{ V}$ |
| 5 V Swing | | ±4 | | ps/°C | Measured 10%–90%, $V_{L} = 0 \text{ V}$, $V_{H} = 5 \text{ V}$ |
| Overshoot and Preshoot | | <3 + 50 | | % of Step + mV | $V_{\rm L}$, $V_{\rm H} = -0.1$ V, 0.1 V, $V_{\rm L}$, $V_{\rm H} = 0.0$ V, 1.0 V |
| | | 50 | | | V_L , $V_H = 0.0 \text{ V}$, 3.0 V , V_L , $V_H = 0.0 \text{ V}$, 5.0 V |
| | | | | | V_{L} , $V_{H} = -2.0 \text{ V}$, 7.0 V |
| Settling Time | | | | | |
| to 15 mV | | < 50 | | ns | $V_L = 0 \text{ V}, V_H = 0.5 \text{ V}, V_T = -2 \text{ V}$ |
| to 4 mV | 1 | <10 | | μs | $V_{\rm L} = 0 \text{ V}, V_{\rm H} = 0.5 \text{ V}, V_{\rm T} = -2 \text{ V}$ |

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| Parameter | Min | Тур | Max | Unit | Test Conditions |
|---|-----|--------|-----|----------------|---|
| Delay Change vs. Pulsewidth | | 50 | | ps | $V_L = 0 \text{ V}, V_H = 2 \text{ V}, \text{ Pulsewidth} = 2.5 \text{ ns}/7.5 \text{ ns}, 30 \text{ ns}/90 \text{ ns}$ |
| Minimum Pulsewidth | | | | | |
| 3 V Swing | | 1.4 | | ns | $V_L = 0 \text{ V}, V_H = 3 \text{ V}, 90\% (2.7 \text{ V}) \text{ Reached, Measure } @ 50\%$ |
| 5 V Swing | | 2.0 | | ns | $V_L = 0 \text{ V}, V_H = 5 \text{ V}, 90\% (4.5 \text{ V}) \text{ Reached, Measure } @ 50\%$ |
| Toggle Rate | | 250 | | MHz | $V_L = 0 \text{ V}, V_H = 5 \text{ V}, VDUT > 3.0 \text{ V p-p}$ |
| DYNAMIC PERFORMANCE, INHIBIT | | | | | |
| Delay Time, Active to Inhibit | | 3.3 | | ns | Measured at 50%, $V_H = +2 \text{ V}$, $V_L = -2 \text{ V}$, $V_T = 0 \text{ V}$ |
| Delay Time, Inhibit to Active | | 2.9 | | ns | Measured at 50%, $V_H = +2 \text{ V}$, $V_L = -2 \text{ V}$, $V_T = 0 \text{ V}$ |
| Delay Time Matching (Z) | | <2 | | ns | Z = Delay Time Active to Inhibit Test (Above)— |
| | | | | | Delay Time Inhibit to Active Test (Above) |
| | | | | | (Of Worst Two Edges) |
| I/O Spike | | 150 | | mV, p-p | $V_{H} = 0 \text{ V}, V_{L} = 0 \text{ V}, V_{T} = 0 \text{ V}$ |
| Rise, Fall Time, Active to Inhibit | | 1.6 | | ns | $V_{\rm H}$ = +2 V, $V_{\rm L}$ = -2 V (Measured 20%/80% of 1 V Output) |
| Rise, Fall Time, Inhibit to Active | | 1.4 | | ns | $V_{H} = +2 \text{ V}, V_{L} = -2 \text{ V} \text{ (Measured 20\%/80\% of 1 V Output)}$ |
| DYNAMIC PERFORMANCE , V _{TERM} | | | | | |
| Delay Time, V _H to V _{TERM} , V _L to V _{TERM} | | 2.5 | | ns | Measured at 50%, $V_L = -1 V$, $V_H = +1 V$, $V_{TERM} = 0 V$ |
| Delay Time, V _{TERM} to V _H and V _{TERM} to V _L | | 2.5 | | ns | Measured at 50%, $V_L = V_H = +0.4 \text{ V}$, $V_{TERM} = -0.4 \text{ V}$ |
| Overshoot and Preshoot | | <3.0 + | 75 | % of Step + mV | V_{H}/V_{L} , $V_{TERM} = (0 \text{ V}, -1 \text{ V})$, $(0 \text{ V}, -2.0 \text{ V})$, |
| | | | | | (0 V, 6.0 V) |
| V _{TERM} Mode Rise Time | | 2.2 | | ns | $V_L = -2 \text{ V}, V_H = +2 \text{ V}, V_{TERM} = 0 \text{ V}, 20\% - 80\%$ |
| V _{TERM} Mode Fall Time | | 2.2 | | ns | $V_L = -2 \text{ V}, V_H = +2 \text{ V}, V_{TERM} = 0 \text{ V}, 20\%-80\%$ |
| PSRR, DRIVE or TERM Mode | | 35 | | dB | $V_S = V_S \pm 3\%$ |

Specifications subject to change without notice.

COMPARATOR SPECIFICATIONS

(All specifications are at $T_J=85^{\circ}C\pm5^{\circ}C$. [Outputs terminated in 150 Ω to GND, $+V_S=11~V\pm3\%~-V_S=6~V\pm3\%$, VCCO = 3.3 V unless otherwise specified.] All temperatures coefficients are measured at $T_J=75^{\circ}C$ to 95°C.)

| Parameter | Min | Тур | Max | Unit | Test Conditions |
|---|-------------|-------|------------|-------|--|
| DC INPUT CHARACTERISTICS | | | | | |
| Offset Voltage (VOS) | -25 | | +25 | mV | CMV = 0 V |
| Offset Voltage (Drift) | | 50 | | μV/°C | CMV = 0 V |
| HCOMP, LCOMP Bias Current | -50 | | +50 | μA | $V_{IN} = 0 V$ |
| Voltage Range (V _{CM}) | -2 | | +7.0 | V | |
| Differential Voltage (V _{DIFF}) | | | 9.0 | V | |
| Gain and Linearity | -0.05 | | +0.05 | % FSR | $V_{IN} = -2 V \text{ to } +7 V (9 V FSR)$ |
| LATCH ENABLE INPUTS | | | | | |
| Logic "1" Current (I _{IH}) | | | 250 | μΑ | LEA, $\overline{\text{LEA}}$, LEB, $\overline{\text{LEB}} = +3 \text{ V}$ |
| Logic "0" Current (I _{II}) | -250 | | | μA | LEA, \overline{LEA} , LEB, $\overline{LEB} = -2 \text{ V}$ |
| Logic Input Range | -2 | | +3 | v | |
| DIGITAL OUTPUTS | | | | | |
| Logic "1" Voltage (V _{OH}) | VCCO - 0.98 | | | V | Q or \overline{Q} , 16.7 mA Load |
| Logic "0" Voltage (V _{OL}) | | | VCCO - 1.5 | V | $Q \text{ or } \overline{Q}, 10 \text{ mA Load}$ |
| Slew Rate | | 1 | | V/ns | (11 () 11 1111 - 11111 |
| VCCO Range | 0 | _ | 8 | V | |
| SWITCHING PERFORMANCE | | | | | |
| Propagation Delay | | | | | |
| Input to Output | | 1.8 | | ns | $V_{IN} = 2 V p-p,$ |
| Latch Enable to Output | | 2 | | ns | HCOMP = 1 V, LCOMP = 1 V |
| Propagation Delay Temperature Coefficient | | 2 | | ps/°C | |
| Propagation Delay Change with Respect to | | | | | |
| Slew Rate: 0.5 V, 1.0 V, 3.0 V/ns | | <±100 | | ps | $V_{IN} = 0 V \text{ to } 5 V$ |
| Slew Rate: 5.0 V/ns | | <±350 | | ps | $V_{IN} = 0 V \text{ to } 5 V$ |
| Amplitude: 1.0 V, 3.0 V, 5.0 V | | <±200 | | ps | $V_{IN} = 1.0 \text{ V/ns}$ |
| Equivalent Input Rise Time | | 450 | | ps | $V_{IN} = 0 \text{ V to } 3 \text{ V}, 3 \text{ V/ns}$ |
| Pulsewidth Linearity | | <±200 | | ps | $V_{IN} = 0 \text{ V to } 3 \text{ V}, 3 \text{ V/ns}, PW = 3 \text{ ns-8 ns}$ |
| Settling Time | | 25 | | ns | Settling to ± 8 mV, $V_{IN} = 1$ V to 0 V |
| Latch Timing | | | | | |
| Input Pulsewidth | | 1.68 | | ns | |
| Setup Time | | 1.0 | | ns | |
| Hold Time | | 1.1 | | ns | |
| Hysteresis | | 6 | | mV | Latch Inputs Programmed for Hysteresis |

Specifications subject to change without notice.

AD53509-SPECIFICATIONS

ACTIVE LOAD SPECIFICATIONS

(All specifications are at $T_J = 85^{\circ}\text{C} \pm 5^{\circ}\text{C}$, $+V_S = 11 \text{ V} \pm 3\%$, $-V_S = -6 \text{ V} = \pm 3\%$ unless otherwise noted. All temperature coefficients are measured at $T_J = 75^{\circ}\text{C}$ to 95°C.)

| Parameter | Min | Typ | Max | Unit | Test Conditions |
|---------------------------------------|-----------|------|------------|-------------------------|--|
| INPUT CHARACTERISTICS | | | | | |
| INHL, INHL | | | | | |
| Input Voltage | -2 | | +3 | V | $IOHC = 1 \text{ V}, IOLC = 1 \text{ V}, VCOM = 2 \text{ V}, OUT_L = 0 \text{ V}$ |
| Bias Current | -250 | | 250 | μA | $INHL$, $\overline{INHL} = -2 \text{ V}$, $+3 \text{ V}$ |
| IOHC Current Program Range | | | | | |
| IOH = 0 mA to -40 mA | 0 | | 4 | V | $OUT_L = -0.7 \text{ V}, +7 \text{ V}$ |
| IOLC Current Program Range | | | | | |
| IOL = 0 mA to +40 mA | 0 | | 4 | V | $OUT_L = -2 V, +5.7 V$ |
| IOHC, IOLC Input Bias Current | -300 | | +300 | μA | IOLC = 0 V, 4.0 V and IOHC = 0 V, 4.0 V |
| IOLRTN, IOHRTN Range | -2 | | +7 | v | $IOL = +40 \text{ mA}, IOH = -40 \text{ mA}, OUT_L = -2 \text{ V}, +7 \text{ V}$ |
| VDUT Range | -2 | | +7 | V | $IOL = +40 \text{ mA}$, $IOH = -40 \text{ mA}$, $IOUT_L-VCOMI > 1.3 \text{ V}$ |
| VDUT Range, IOH = 0 mA to -40 mA | -0.7 | | +7 | V | OUT_L-VCOM > 1.3 V |
| VDUT Range, IOL = 0 mA to +40 mA | -2 | | +5.7 | V | VCOM-VDUT > 1.3 V |
| VCOMI Input Range | -2 | | +7 | V | IOL = +40 mA, IOH = -40 mA |
| OUTPUT CHARACTERISTICS | | | | | |
| Accuracy | | | | | |
| Absolute Accuracy Error, Load Current | -0.3 - 10 | 00 | +0.3 + 100 | % I _{SET} + μA | IOL, IOH = $25 \mu A-40 \text{ mA}$, VCOM = 0 V , OUT_L = $\pm 2 \text{ V}$ and |
| | | | | | IOL = $25 \mu A-40 \text{ mA}$, VCOM = $+7 \text{ V}$, OUT_L = $+5.7 \text{ V}$ and |
| | | | | | IOH = 25 μ A-40 mA, VCOM = -2 V, OUT_L = -0.7 V |
| VCOM Buffer | | | | | |
| Offset Error | -50 | | +50 | mV | IOL , $IOH = 40 \text{ mA}$, $VCOMI = 0 \text{ V}$, $OUT_L = VCOM$ |
| Bias Current | -10 | +1 | +10 | μΑ | VCOMI = 0 V, OUT_L = VCOM |
| Gain Error | -0.2 | | +0.2 | % | IOL, IOH = 40 mA , VCOMI = -1 V to $+6 \text{ V}$, |
| | | | | | VOUT = VCOM |
| Linearity Error | -10 | | +10 | mV | IOL, IOH = 40 mA , VCOMI = $-1 \text{ V to } +6 \text{ V}$, |
| | | | | | VOUT = VCOM |
| Output Current TC | | <±2 | | μA/°C | Measured at IOH, IOL = 200 μA |
| DYNAMIC PERFORMANCE | | | | | |
| Propagation Delay | | | | | |
| $\pm I_{OUT}$ to Inhibit | | 1.9 | | ns | $VCOM = \pm 2 \text{ V}, IOL = +20 \text{ mA}, IOH = -20 \text{ mA}$ |
| Inhibit to $\pm I_{OUT}$ | | 2.8 | | ns | $VCOM = \pm 2 \text{ V}$, $IOL = +20 \text{ mA}$, $IOH = 20 \text{ mA}$ |
| Propagation Delay Matching | | <1.8 | | ns | |
| I/O Spike | | 240 | | mV | VCOM = 0 V, $IOL = +20 mA$, $IOH = -20 mA$ |
| Settling Time to 15 mV | | < 50 | | ns | IOL = $+20$ mA, IOH = -20 mA, 50 Ω Load, to ± 15 mV |
| Settling Time to 4 mV | | <10 | | μs | IOL = +20 mA, IOH = -20 mA, 50 Ω Load, to ± 4 mV |

Specifications subject to change without notice.

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TOTAL FUNCTION SPECIFICATIONS

(All specifications are at $T_J = 85^{\circ}\text{C} \pm 5^{\circ}\text{C}$, $V_S = 11 \text{ V} \pm 3\%$, $-V_S = -6 \text{ V} = \pm 3\%$ unless otherwise noted. All temperature coefficients are measured at $T_J = 75^{\circ}\text{C}$ to 95°C .)

| Parameter | Min | Тур | Max | Unit | Test Conditions |
|---|------|-----|------|------|---|
| OUTPUT CHARACTERISTICS | | | | | |
| Output Leakage Current, $V_{OUT} = -1 \text{ V to } +5 \text{ V}$ | -250 | | +250 | nA | |
| Output Leakage Current, $V_{OUT} = -2 \text{ V}$ to +7 V | -500 | | +500 | μA | |
| Output Capacitance | | 8 | | pF | Driver and Load INHIBITED |
| POWER SUPPLIES | | | | | |
| Total Supply Range | | 17 | | V | |
| Positive Supply | | 11 | | V | |
| Negative Supply | | -6 | | V | |
| Positive Supply Current | | | 280 | mA | Driver = I _{NH} , I _{LOAD} Program = 40 mA, Load = Active |
| Negative Supply Current | | | 290 | mA | Driver = I_{NH} , I_{LOAD} Program = 40 mA, Load = Active |
| VCCO Current | | 65 | | mA | VCCO = 3.3 V, Comparator Output 150 Ω to GND |
| Total Power Dissipation | | | 4.8 | W | Driver = I_{NH} , I_{LOAD} Program = 40 mA, Load = Active |
| Temperature Sensor Gain Factor | | 1 | | μA/K | $R_{LOAD} = 10 \text{ k}\Omega, V_{SOURCE} = 11 \text{ V}$ |

NOTES

Connecting or shorting the decoupling pins to ground will result in the destruction of the device. Specifications subject to change without notice.

Table I. Driver Truth Table

| DATA | DATA | IOD | ĪŌD | RLD | RLD | OUTPUT STATE |
|------|------|-----|-----|-----|-----|--------------|
| 0 | 1 | 1 | 0 | X | X | $V_{\rm L}$ |
| 1 | 0 | 1 | 0 | X | X | $V_{\rm H}$ |
| X | X | 0 | 1 | 0 | 1 | INH |
| X | X | 0 | 1 | 1 | 0 | V_{TERM} |

Table II. Comparator Truth Table

| voi | U T | LEH | LEH | LEL | <u>LEL</u> | QH | UTPUT STAT | ES QL | <u>QL</u> |
|---|---|-----|------------|-----|------------|------------|-------------------------|------------|----------------------------------|
| >HCOMP | >LCOMP | 1 | 0 | 1 | 0 | 1 | 0 | 1 | 0 |
| >HCOMP | <lcomp< td=""><td>1</td><td>0</td><td>1</td><td>0</td><td>1</td><td>0</td><td>0</td><td>1</td></lcomp<> | 1 | 0 | 1 | 0 | 1 | 0 | 0 | 1 |
| <hcomp< td=""><td>>LCOMP</td><td>1</td><td>0</td><td>1</td><td>0</td><td>0</td><td>1</td><td>1</td><td>0</td></hcomp<> | >LCOMP | 1 | 0 | 1 | 0 | 0 | 1 | 1 | 0 |
| <hcomp< td=""><td><lcomp< td=""><td>1</td><td>0</td><td>1</td><td>0</td><td>0</td><td>1</td><td>0</td><td>1</td></lcomp<></td></hcomp<> | <lcomp< td=""><td>1</td><td>0</td><td>1</td><td>0</td><td>0</td><td>1</td><td>0</td><td>1</td></lcomp<> | 1 | 0 | 1 | 0 | 0 | 1 | 0 | 1 |
| X | X | 0 | 1 | 0 | 1 | QH (t – 1) | \overline{QH} $(t-1)$ | QL (t - 1) | $\overline{\mathrm{QL}}$ $(t-1)$ |

Table III. Active Load Truth Table

| | | | OUTPUT STATES (Including Diode Bridge) | | | | | |
|---|------|------|--|--------------------------------|----------|--|--|--|
| OUT_L | INHL | INHL | ЮН | IOL | I(OUT_L) | | | |
| <vcom< td=""><td>0</td><td>1</td><td>V(IOHC) × 10 mA</td><td>V(IOLC) × 10 mA</td><td>IOL</td></vcom<> | 0 | 1 | V(IOHC) × 10 mA | V(IOLC) × 10 mA | IOL | | | |
| >VCOM | 0 | 1 | V(IOHC) × 10 mA | $V(IOLC) \times 10 \text{ mA}$ | IOH | | | |
| X | 1 | 0 | 0 | 0 | 0 | | | |

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AD53509

ABSOLUTE MAXIMUM RATINGS¹ Power Supply Voltage VCC to GND 13 V VCCO to GND 10 V PWR GND HQ GND ±0.4 V Inputs DATA, \overline{DATA} , IOD, \overline{IOD} , RLD, \overline{RLD} +5 V, -2 V DATA to \overline{DATA} , IOD to \overline{IOD} , RLD to \overline{RLD} $\pm 3 \text{ V}$ LEL, $\overline{\text{LEL}}$, LEH, $\overline{\text{LEH}}$ +5 V, -2 V LEL to $\overline{\text{LEL}}$, LEH to $\overline{\text{LEH}}$ $\pm 3 \text{ V}$ INHL, <u>INHL</u> +5 V, –2 V INHL to INHL ±3 V VH, VL, VTERM, VCOM_I to GND +8 V, -3 V (VH–VTERM) and (VTERM – VL) $\dots \dots \pm 10 \text{ V}$ HCOMP +8 V, -3 V HCOMP, LCOMP to V_{OUT} $\pm 10 \text{ V}$ Outputs V_{OUT} Short Circuit Duration Indefinite² VHDCPL Do Not Connect Except for Cap to V_{CC} VLDCPL Do Not Connect Except for Cap to $V_{\rm EE}$ QH, \overline{QH} , QL, \overline{QL} Maximum I_{OUT} Surge 100 mA THERM 13 V, 0 V IOHRTN, IOLRTN +8.5 V, -3.5 V

Environmental

| Operating Temperature (Junction) | . 175°C |
|---|---------|
| Storage Temperature65°C to | +150°C |
| Lead Temperature (Soldering, 10 sec) ³ | . 260°C |

NOTES

¹Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Absolute maximum limits apply individually, not in combination. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

²Output short circuit protection is guaranteed as long as proper heat sinking is employed to ensure compliance with the operating temperature limits.

Table IV. Package Thermal Characteristics

| Air Flow, FM | θ _{JA} , °C/W |
|--------------|------------------------|
| 0 | 33 |
| 200 | 25 |
| 400 | 22 |

ORDERING GUIDE

| Model | Package Description | Shipment Method Quantity per Shipping Container | Package Option |
|------------|------------------------|---|-------------------|
| AD53509JSQ | 52-Lead LQFP-EDQUAD | 90 | SQ-52 |

CAUTION

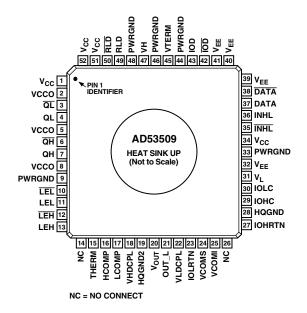
ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although the AD53509 features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high-energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.



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 $^{^3}$ To ensure lead coplanarity (± 0.002 inches) and solderability, handling with bare hands should be avoided and the device should be stored in environments at 24 °C ± 5 °C (75°F ± 10 °F) with relative humidity not to exceed 65%.

PIN CONFIGURATION

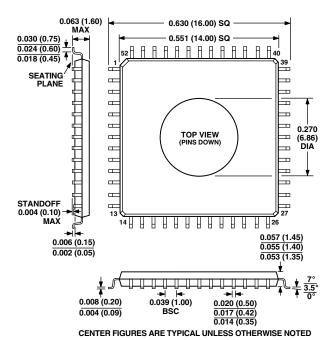


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OUTLINE DIMENSIONS

Dimensions shown in inches and (mm).

52-Lead LQFP-EDQUAD with Integral Heat Slug (SQ-52)



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